

Notice of References Cited

Application/Control No.

10/564,288

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

KIM CHU

Art Unit

2627

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0052181	03-2004	Tada et al.	369/053.22
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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